Abstract Submitted for the DAMOP15 Meeting of The American Physical Society

Field-free junctions for surface electrode ion traps¹ ROBERT JORDENS, National Institute of Standards and Technology, USA, R. SCHMIED, University of Basel, Switzerland, M.G. BLAIN, Sandial National Laboratories, USA, D. LEIBFRIED, D. WINELAND, National Institute of Standards and Technology, USA — Intersections between transport guides in a network of RF ion traps are a key ingredient to many implementations of scalable quantum information processing with trapped ions. Several junction architectures demonstrated so far are limited by varying radial secular frequencies, a reduced trap depth, or a non-vanishing RF field along the transport channel. We report on the design and progress in implementing a configurable microfabricated surface electrode Y-junction that employs switchable RF electrodes. An essentially RF-field-free pseudopotential guide between any two legs of the junction can be established by applying RF potential to a suitable pair of electrodes. The transport channel's height above the electrodes, its depth and radial curvature are constant to within 15%.

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Robert Jordens NIST - Boulder

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